

Minutes of the Microplate Standardization Development Group (MSDG)
At LabAutomation'05, San Jose-California

Date: Feb 02, 2005

By: Amer El-Hage

Attendees and Consensus Body (CB):

Name	Organization	CB member	New member
Deborah Morton	Corning Inc.	Y	
Gunther Knobel	Greiner Bio-One	Y	
Irmgard Suominem	Thermo Electron	Y	
Marcy Engelstein	Millipore	Y	
Amer El-Hage	Beeston engineering Consulting	Y*	
Bruce Turner	Bridge Bioscience Corp	-	yes
Rainer Heller	Greiner Bio-One	“	
Larry Lugo	Aurora Discovery	Y	
Mike Shanler	Becton Dickinson	Y	
Andy Muser	Becton Dickinson	“	
Dagma Weber	Evotec	-	yes
Keith Whiting	Nunc – (Fisher Scientific)	Y	
Christoph Kaufmann	Tecan	Y	
James Fergus	Pfizer	Y	

* Became a CB member after attending this meeting.

Agenda:

Co-Chair, Amer El-Hage called the meeting to order at 3:03 pm. The following proposed agenda was reviewed.

- 1- Call to order, update membership and Consensus body (CB) members for a quorum and voting
- 2- Review and approve last meeting minutes
- 3- Committee updates since last meeting
- 4- Discussion of proposed standard for plate flatness – Standard 6
- 5- Other issues- Nominations for a Co-chair
- 6- Summary and adjournment

Amer asked if anyone would like to change anything. The agenda approved with no change.

Amer reviewed the legal summary guidelines and the SBS Standards Setting Committee guidelines.

Committee Update

See if we have a Quorum. Of the new consensus body, 10 were present at the meeting. A quorum was established. We also do this if we find a need to vote.

To become a consensus member company – One needs to attend 2 of the previous 4 meetings.

The CB membership prior to the meeting consisted of the following organizations (17):

1. Fisher Scientific (Apogent , NUNC, Abgene) ^{1,2}	2. Aurora Discovery ^{1,2}
3. REMP ²	4. Corning ¹
5. Millipore ¹	6. Thermo Electron ^{1,2}
7. Weidmann Plastics ¹	8. Beckman Coulter ²
9. Greiner BioOne ¹	10. Tecan ²
11. Pfizer ³	12. Merck ³
13. BD Biosciences ^{1,2}	14. Boehringer-Ingelheim ³
15. Wyeth ³	16. Innovative Microplate ¹
17. Molecular Devices (Axon, Skatron, LJLBio, Universal Imaging) ^{1,2}	

Interest groups

1. Manufacturers of microplates (n= 10)
2. Manufacturers of instrumentation that utilizes microplates (n= 7)
3. Users of microplates that do not fit in either of the previous categories (n= 4)

NOTE: Total greater than 17 because 4 organizations represented two interest groups

ANSI Approved Proposed Microplate Standards:

The microplate Standards Development Committee (MSDC) is an interest group that meets typically at 1 or 2 meetings per year. Typically we meet at SBS and at LabAutomation conferences.

Membership is open to anyone interested in microplates, and an individual or organization does not have to be an SBS or ALA member to join this group.

SBS is an approved ANSI Standards Development Organization. The MSDC writes the standards, and then submit it to the CB for vote and approval then to ANSI. We have four 4 ANSI approved Standards.

Legal Summary guidelines review. Standards Setting Committee Guidelines Review and approve last meeting minutes. Minutes published in October, open for comments. No comments, so approved. Minutes will be filed on the Listserv.

Committee updates since last meeting. MSDC/SBS had a preliminary audit by ANSI – Review required changes. Will publish audit results by next meeting.

Review of Standard SBS-5

Discussion of proposed standard for plate flatness (see Appendix for detail discussion)

Discussion on New or additional Standards:

Other issues – Nominations/Volunteers for a Co-Chair

Amer asked if anyone would like to nominate for this position. Mike Shanler (BD) volunteered, and it was second by Keith Whiting (NUNC).

Other candidates can be nominated and we can vote online – We can also have candidates and approval by SBS.

Amer asked if there were any ideas for new standards. Mike Shanler suggested one for auto-fluorescence and/or background noise. Material restrictions, some companies have licenses on some films, beginning to see a marketing need for this kind of thing.

Amer – It could be a QC thing – We have to define instrumentation or means of measuring, someone mentioned transmission or haze. Is that important to anyone?

Next Meeting:

The next MSDC meeting will be held at SBS in Geneva, Switzerland in September 2005.

Minutes, agenda and dates will be posted on the users' online group.

The meeting was adjourned by Amer El-Hage at 4:30 pm.

Appendix

Transcript of the discussion on well bottom standard

Thank you, Ms. Deb Morton (Corning).

- a. Amer - Last heard we leave to mfg to determine, they decide, and guarantee to certain confidence
- b. Mike Shandler - We do 9 point flatness for spec on 384, 9 point also on 96.
- c. Deb Morton (Corning)- Need individuals to state name or organization when first talking.
- d. Amer El-Hage(Beeston Engineering)- Tend to agree
- e. Mike Shanler (BD) - What about using x number per sq millimeter?
- f. Andy ??- BD - Take multiple within well, then all wells when qualifying tool then use 9 for verification - question of who needs and what are real requirements
- g. Mike S. - customer should be able to do this
- h. Gunther K. (Greiner) - Need qualifying tool - on first time versus routine 9-24, recommend to leave # wells open, mfg know any specific measurements and requirements in order to meet range, mfg know process best internally, Rec - Min, Max, Range, have to look at in general items, depends on product solid vs. thin film, error in plate, contact versus non-contact, vs optically.

- i. Amer - not fixed dimension, depends on customer
- j. Deb - Measurement standard - no input from equip manufacturers
- k. Mike - if did define wells then have to define where
- l. Dogma, Evotec - in addition to flatness of plate, need flatness within one well,
- m. Mike - BD bought Atto BioEngineering - learning that delta from well to well has more drastic effect particularly if there is bow in plate. Definitely need more input from equipment side
- n. Front row? - work for V bot
- o. Me - intended to work for everything, makes sense to have a spec for intra well flatness
- p. Amer - talk about measurement procedure for intrawell - any suggestions on how to do this?
- q. Dogma (Evotec) - three point within one well, better to measure 5 points
- r. Amer - define method - David as is brought scan of whole plate, scan or put number of measurements, do we think that we don't need to specify number of data points for plate flatness, intra well - ?
- s. Me
- t. Mike - contact measurements for 1536 not real useful
- u. Andy - even some imagers - using confocal lense to measure - sometimes difficult depending on the depth of the well
- v. Dogma - measure from the bottom - best to scan and have small scan, not good for everyone
- w. Mike - 90 % customers using bottom detection
- x. Amer - put something in the standard for Intra well, Min, Max, Range - stay with the same type of thing
- y. Amer - not number of plates either, Tw metrics same for intra and across plate, no mention so far of uniformity, is it needed?, Useful
- z. Dogma - Would be helpful to have more info on bending across plate and within well.
- aa. Amer - that is possible.
- bb. Larry Lugo (Aurora Discovery)- measure with own reader - so many different kinds of well bottoms, all looking for different uses for our plates, doesn't feel like we could come up with a common standard, use scanning, what is the end product out of all of this? Determine this before we continue
- cc. Amer - someone suggested we needed a way to define the flatness of a plate, what does that mean? I appreciate the comment, what is our goal? It is not a number or dimension that we are trying to come up with, trying to come out of with this standard so that there is a common language
- dd. Larry - even that becomes difficult - defining flatness in 100 microns, others don't care, flatness means different things to different plates, too loose for assay or too tight for dispensing
- ee. Amer - encourage everyone to think about why we need the standard, purpose of the standard, believe in defining the method, I have some rating, define the level of flatness, after we define the method, dispensing - mm, imaging another rating - like flange one, we allow differences
- ff. Andy - just to have it in there as a definition so that everyone knows what flatness means
- gg. Amer - general guidelines on who to test MEMS device - effort to define the procedure - what does a clean room mean - how do you interface, when say silicon what does it mean

- hh. Larry - come up with guidelines - flatness from bottom of plate, from bottom of well
- ii. Amer - needing more of a guideline, Corning proposal a good start, maybe we don't need to go further, don't have to come up with
- jj. Larry - is there a third flatness that we need to define
- kk. Deb Morton (Corning)- did I hear correctly that we need a separate section for measuring top versus bottom of the wells, top reader versus bottom reader
- ll. Amer - well bottom is two places, flatness from top, flatness from bottom, flatness on well
- mm. Deb - Top, bottom, well surface?
- nn. Keith Whitlander (Fisher-NUNC)- Qualify by WB Interior, Exterior, at minimum draft is good as it gives definition if xyz claims WBE to be certain value have good idea as to how it's being measured, understand concern of mfg where specs need to be much more stringent, for garden variety has value in defining how it's being measured.
- oo. Amer - What did you mean?
- pp. Keith - Draft provides good amount of info, can give standard to customer, this is what we mean
- qq. Amer - up to the maker to put a value?
- rr. Keith - customer has good idea of how mfg reached the values
- ss. Amer - Min, Max, everyone agrees these are basics for the standard
- tt. Andy - don't think WB Exterior has much value because importance in the well is if the thickness is off can crash objective
- uu. Larry - compensate for lack flatness by mapping, use auto focus to read, good plate for them is like glass
- vv. Andy- WB Exterior, need to be able to detect, might need thickness
- ww. Larry - film thickness and glass
- xx. Keith - common language - be very specific
- yy. Amer - WBE Interior, WBE Exterior, Flatness within the well
- zz. Andy - doesn't like Interior vs. Exterior, but we need something
- aaa. Larry - See if marketing folks would like this
- bbb. Tecan - what about plate flatness? "Plate Bottom height
- ccc. Deb - What about Plate Bottom Elevation?
- ddd. Amer - "Plate Bottom Elevation - PBE similar to WBE
- eee. Mike - Lens thickness - most crucial for us, what customers are interested in
- fff. Tecan - Well Bottom Thickness
- ggg. Andy - Lens Thickness
- hhh. Andy - Intrawell Flatness
- iii. Andy - WBEV - with respect to tolerance?
- jjj. Deb - independent - range only
- kkk. Other discussion items okay - do we need to discuss
- lll. Amer - don't want to specify tool
- mmm. Gunther K. - (Greiner) - more confusing or are they helpful - Try to define application to end user - need to carry out what kinds of bottoms, will depend highly on the material of the bottom, if films then need thick and thin films, no particular preference right now but think it may be confusing, how would you measure IW. 1536 in diam of .9mm at bottom, how would you measure?
- nnn. Amer - Let us go back to the purpose
- ooo. Rainer Heller (Greiner)- customer wants to know if plate useful for their application, ask if suitable, total flatness necessary for all plates, this inner well only for microscopic applications, have to split out, some customers don't ask for. Solid bottom 96 noone

- cares about. Limits and tolerances come from microscopes in some applications and microscopes. More is just confusing for me
- ppp. Larry - three measurements, not saying would have to have a spec for all three
- qqq. Amer - not saying that flat plate must have addressed all three, what we're saying flat based on one of these three definitions, some need one, some others, some all three.
- rrr. Millipore - isn't here already another flatness
- sss. Gunther - already defined overall plate flatness in reference to datum A
- ttt. Millipore - geared to higher tech
- uuu. Amer - As I understand it the main drivers are the imaging and touch dispensing
- vvv. Jim Furgus (Pfizer) - most applications don't need to know details until get into imaging, so can compare and buy from best vendor, willing to pay price up front. Need to have all vendors with the same values, we will shop based on these values.
- www. Mike - really an imaging plate standard
- xxx. Jim, used to also be contact dispensing issue but getting away from that
- yyy. Greiner - marketing - most of requirements coming from imaging, Evotec, pge, Aurora
- zzz. Larry - IW isn't critical for them, but for wetting and washing it might be
- aaaa. Mike - for ultra high throughput IW not important
- bbbb. Amer - is all we need one? Is this more than we need?
- cccc. Mike - post and get feedback - WBE most important - see what we get.
- dddd. Amer - take as action item - see what get on list serv, don't care, give us one number, or like the segregation
- eeee. Deb - should we add to the draft or separate
- ffff. Mike - rather see in the draft with copy of graphic
- gggg. Deb - will add new definitions to the draft and publish to the listserv.